

**Search Notes**

Application/Control No.

10/661,852

Examiner

Ellen C. Tran

Applicant(s)/Patent under  
Reexamination

RAGHUNATH ET AL.

Art Unit

2134

**SEARCHED**

Class	Subclass	Date	Examiner
726	20	7/18/2007	ET
726	9	7/18/2007	ET
713	156	7/18/2007	ET
713	185	7/18/2007	ET
713	186	7/18/2007	ET

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	7/18/2007	ET
NPL - IEEE XPLORER	7/18/2007	ET
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTION	7/18/2007	ET

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner